## Kaleo MTF MTF \& WFE

 measurement stationfor wide angle lenses

# PHASICS 

The phase control company

# An automated test instrument for alignment and optical quality measurement 

PHASICS innovative solution delivers the most complete lens characterization: on \& off-axis MTF and wave front error at multiple wavelengths. It benefits from PHASICS patented technology to provide accurate results even for large field of view. The Kaleo MTF instrument is ideal for measuring small sets of lenses, at the design, prototyping or production phase. It can be used either by production operators with an easy, step-by-step procedure, or by R\&D engineers with access to more features and settings. One single acquisition provides comprehensive characterization!

## MARKETS


Automotive ADAS

Security

Drones

Mobile phone

## LENS CHARACTERIZATION



Aberrations of a complex zoom lens with high NA (F/2)
$\longrightarrow 450 \mathrm{~nm} \longrightarrow 530 \mathrm{~nm} \longrightarrow 660 \mathrm{~nm}$

## OUTCOMES

- On-axis \& off-axis MTF
- Through focus MTF
- Transmitted wave front error
- Zernike polynomials
- Lens parameters : EFL, f\#
- OPD in the lens exit pupil
- Astigmatism
- Distortion
- Field curvature
- Relative illumination


## ADVANTAGES

- Single shot measurement
- Fully automated measurement process
- No need to realign for off-axis measurement
- Easy alignment
- Autofocus
- Manual or motorized sample holder
- Single or multiple lens tray
- Cost effective solution
- Accuracy similar to interferometry
- MTF measurement up to cut-off frequency
- Several wavelengths (RGB + IR by default)
- High quality collimated source
- Measurement at several azimuths


## SOFTWARE

## ACQUISITION MANAGEMENT

- Possibility to select wavelengths, field angles, number of iterations (for repeatability assessment)
- Real time display of relative illumination and intensity
- Settings database


## RESULTS MANAGEMENT

- Selection of computed and saved parameters
- Aberration and MTF vs field angle for each wavelength and azimuth
- Possibility to post-process data after acquisition


## INTERFACE MANAGEMENT

- Supervisor interface: access to all parameters and settings
- Operator interface: quick and easy-to-use for optimal throughput


## Kaleo MTF on \& off-AxIS TESTING

## SPECIFICATIONS

| MTF on-axis | Accuracy $<1 \% *$ <br> Repeatability $<0.5 \% *$ |
| :--- | :--- |
| MTF off-axis | Accuracy $<2 \% * *$ <br> Repeatability $<1 \% * *$ |
| MTF max frequency | 1000 cc/mm |
| MTF accuracy | LWIR \& MWIR $\pm 0.02 / \pm 0.03$ |
| SWIR \& Visible $\pm 0.01 / \pm 0.02$ |  |
| MTF repeatability | LWIR \& MWIR $\pm 0.015$ |
|  | SWIR \& Visible $\pm 0.01$ |

* This specification is obtained for optics measured at 660 nm for 3 frequencies and a chief ray angle below $8^{\circ}$.
** This specification is given over the whole field of view.


## FUNCTIONALITIES

| Optical set up | Finite to infinite configuration |
| :--- | :--- |
| Wavelength range | $400-1100 \mathrm{~nm} / 900-1700 \mathrm{~nm} / 3-5 \mu \mathrm{~m} / 8-14 \mathrm{\mu m}$ |
| Entrance pupil diameter | Up to 8.8 mm |
| Diameter range | 2 to 200 mm |
| f\# | $>1.8$ |
| Focal length range | 5 to 500 mm |
| Flange focal length | 8 to 30 mm |
| Field of view | Up to $\pm 120^{\circ}$ |
| Azimuth | $0^{\circ}, 90^{\circ}, 180^{\circ}, 270^{\circ}$, motorized |
| Dimensions (height $\times$ width $\times$ depth) | $1520 \mathrm{~mm} \times 650 \mathrm{~mm} \times 840 \mathrm{~mm}$ |
| Weight | 195 kg |
| Sample holder $/$ Tray | Manual or motorized, single or multiple lens tray |



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